UNITED STATES
PATENT AND TRADEMARK OFFICE



Patents artificial intelligence tools

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Patent Public Advisory Committee quarterly meeting



Patent auto-classification

Vision: Develop auto-classification system to generate CPC data to meet internal needs and international obligations for classification.

- The USPTO is developing and validating an Al-based auto-classification system
 - Full classification of patent documents
 - Identification of CPC symbols associated with claims (called C* or "C-stars")

	CPC allocations	C *
	G01S 7/4863	*
	G01S 7/4865	*
$\{$	G01S 7/4917	
	G01S 13/89	*
	G01S 7/4914	*
	G01S 17/894	
		1



Current activity in auto-classification

Auto-C*

- Implementation of auto-C* started December 2020; monitoring of quality data
- Quality assurance process limited sample of applications immediately following classification

	+/- agreement with CPC + C*	+/- agreement of C* when underlying CPC is correct
Auto-class C* vs. control (250 applications / month)	- 1.7 %	+ 0.6%

- Classification challenge process review of classification after application assigned to an examiner
 - Pilot ongoing through July to accelerate data capture

Full classification

- Currently AI models produce ranked list of CPC symbols for patent applications
- Patent documents have a subset of CPC symbols (typically a few to a dozen) assigned
- Development of CPC symbol assignment capability underway



Al-based search tools for patents

Prototype Release Mature Repeat

Prototyping

- Developing next AI prototype capabilities: new similarity-based sorting, document clustering
- Refining user experience of matured AI prototypes to prepare for full release

Operationalization

- Preparing cloud infrastructure to support releases of AI capabilities to full examining corps
- "More Like This" will be first AI capability available to all examiners with PE2E Search
- Identification of further AI capabilities for full release underway

Value Determination

Testing approaches and infrastructure for metrics capture are both under development





Thank you!

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